

Search Notes 	Application/Control No. 10/570,904	Applicant(s)/Patent under Reexamination TAKESHIMA ET AL.
	Examiner YONG D. PAK	Art Unit 1652

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
435	190	9/23/2008	YP
435	440	9/23/2008	YP
536	23.2	9/23/2008	YP
stic: seq id no:1		9/23/2008	YP